

Contribution ID: 96 Type: Oral presentation

## Precision Timing Measurement with MicroPattern Detectors

Thursday 25 May 2017 13:00 (30 minutes)

Invited talk

Presenter: WHITE, Sebastian (CERN/Princeton University (US))

Session Classification: Related detector technologies (e.g. RPC's and TPC's) - 1 (Chair: Bernd Sur-

row)